

# AOT290L/AOB290L

## 100V N-Channel MOSFET

## **General Description**

The AOT290L/AOB290L uses Trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Power losses are minimized due to an extremely low combination of  $R_{\rm DS(ON)}$  and  $C_{\rm rss}$ .In addition, switching behavior is well controlled with a soft recovery body diode.This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

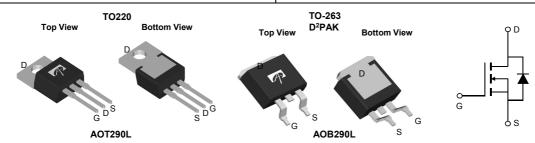
## **Product Summary**

 $V_{DS}$  100V  $I_{D}$  (at  $V_{GS}$ =10V) 140A

 $R_{DS(ON)}$  (at  $V_{GS}$ =10V) < 3.5m $\Omega$  (< 3.2m $\Omega$ \*)

100% UIS Tested 100% R<sub>a</sub> Tested





Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		$V_{DS}$	100	V	
Gate-Source Voltage		$V_{GS}$	±20	V	
Continuous Drain	T <sub>C</sub> =25°C		140		
Current <sup>G</sup>	T <sub>C</sub> =100°C	'D	110	A	
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	500	$\exists$	
Continuous Drain	T <sub>A</sub> =25°C		18	^	
Current	T <sub>A</sub> =70°C	IDSM	15	A	
Avalanche Current <sup>C</sup>		I <sub>AS</sub> , I <sub>AR</sub>	100	Α	
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub> , E <sub>AR</sub>	500	mJ	
V <sub>DS</sub> Spike	10µs	V <sub>SPIKE</sub>	120	V	
	T <sub>C</sub> =25°C		500	W	
Power Dissipation B	T <sub>C</sub> =100°C	P <sub>D</sub>	250	VV	
	T <sub>A</sub> =25°C	В	2.1	W	
Power Dissipation <sup>A</sup> T <sub>A</sub> =70°C		P <sub>DSM</sub>	1.3	VV	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C	

Thermal Characteristics								
Parameter	Symbol	ymbol Typ Max		Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	12	15	°C/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	50	60	°C/W			
Maximum Junction-to-Case	Steady-State	$R_{\theta,IC}$	0.25	0.3	°C/W			

<sup>\*</sup> Surface mount package TO263



### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Тур	Max	Units	
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V				V	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V			1		
	Zero Gate Voltage Drain Current	T <sub>J</sub> =55°C			5	μΑ	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V			100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		3.5	4.1	V	
$I_{D(ON)}$	On state drain current	V <sub>GS</sub> =10V, V <sub>DS</sub> =5V				Α	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A		2.7	3.5		
		TO220 T <sub>J</sub> =125°	0	4.4	5.7	mΩ	
	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A					
		TO263		2.5	3.2	2	
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A		50		S	
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.67	1	V	
Is	Maximum Body-Diode Continuous Curr			140	Α		
DYNAMIC	CPARAMETERS		•				
C <sub>iss</sub>	Input Capacitance			7180	9550	pF	
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz		2780	3700	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			42	72	pF	
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		1.7		Ω	
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge			90	126	nC	
$Q_{gs}$	Gate Source Charge	$V_{GS}$ =10V, $V_{DS}$ =50V, $I_{D}$ =20A		33		nC	
$Q_{gd}$	Gate Drain Charge			21		nC	
$t_{D(on)}$	Turn-On DelayTime			31	69	ns	
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =50V, $R_{L}$ =2.5 $\Omega$ ,		24	53	ns	
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}$ =3 $\Omega$		45	99	ns	
t <sub>f</sub>	Turn-Off Fall Time			27	60	ns	
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=500A/μs		65	91	ns	
$Q_{rr}$	Body Diode Reverse Recovery Charge	l <sub>F</sub> =20A, dl/dt=500A/μs		460	644	nC	

A. The value of R<sub>0JA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation  $P_{DSM}$  is based on R  $_{\theta JA}$  and the maximum allowed junction temperature of 150 $^{\circ}$  C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub> =25° C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175 $^{\circ}$  C. The SOA curve provides a single pulse rating.

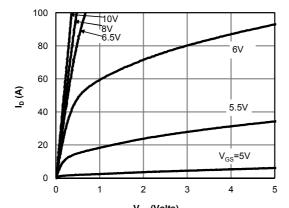
G. The maximum current limited by package.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

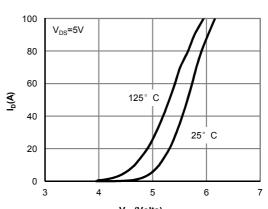
I. The spike duty cycle 5% max, limited by junction temperature  $T_{J(MAX)}$ =120 $^{\circ}$  C.



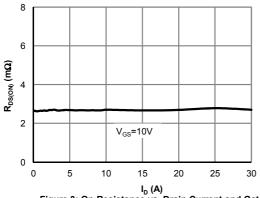
### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 $V_{DS}$  (Volts) Fig 1: On-Region Characteristics (Note E)



V<sub>GS</sub>(Volts) Figure 2: Transfer Characteristics (Note E)



I<sub>D</sub> (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

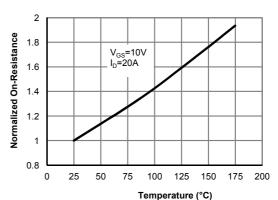
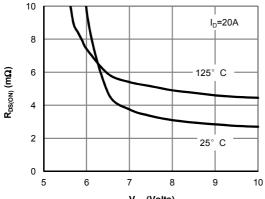
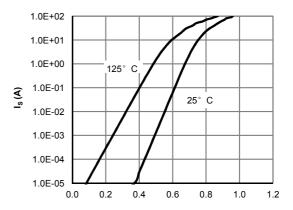


Figure 4: On-Resistance vs. Junction Temperature (Note E)



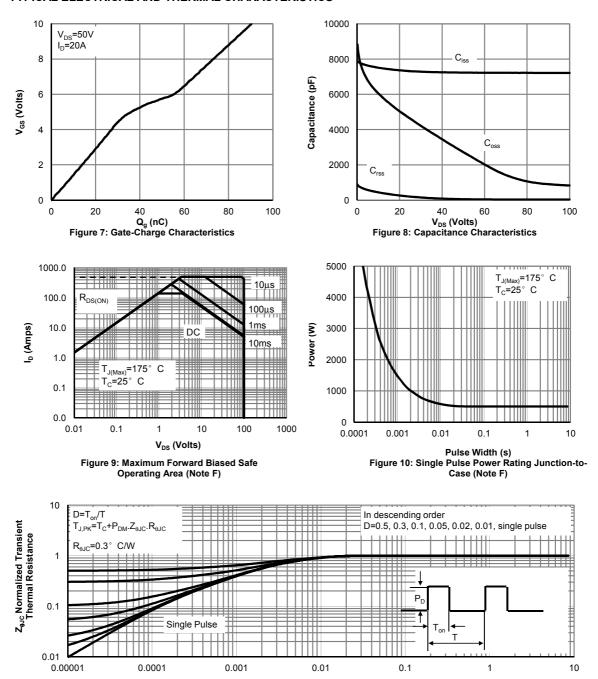
V<sub>GS</sub> (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

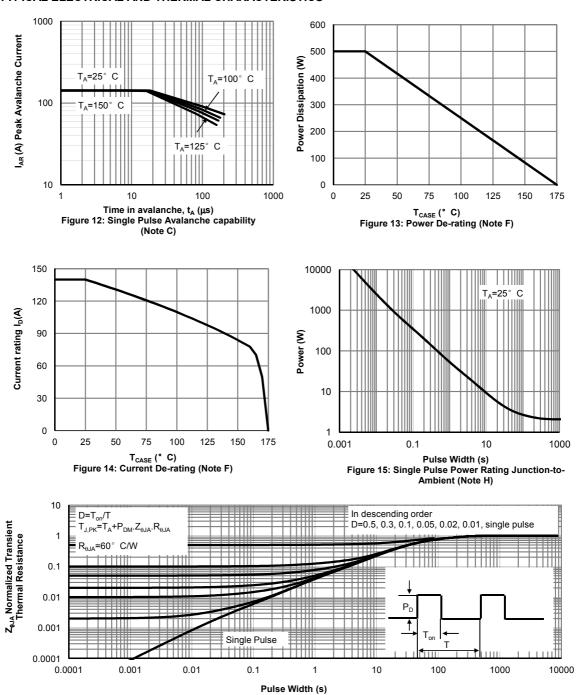
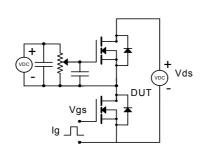
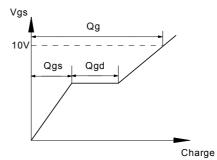


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

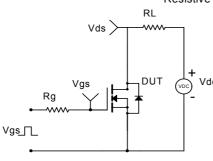


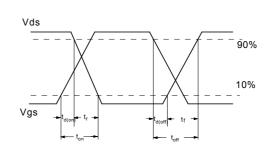
## Gate Charge Test Circuit & Waveform



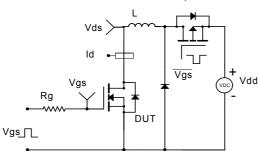


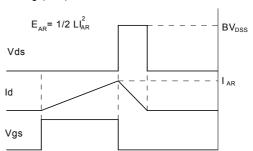
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

